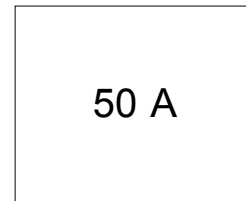


MEDIUM POWER THYRISTORS

Stud Version

Features

- High current rating
- Excellent dynamic characteristics
- $dv/dt = 1000V/\mu s$ option
- Superior surge capabilities
- Standard package
- Metric threads version available
- Types up to $1600V V_{DRM}/V_{RRM}$



Typical Applications

- Phase control applications in converters
- Lighting circuits
- Battery charges
- Regulated power supplies and temperature and speed control circuit
- Can be supplied to meet stringent military, aerospace and other high-reliability requirements

Major Ratings and Characteristics

| Parameters | 50RIA | | Units |
|-------------------|-------------|--------------|-------------|
| | 10 to 120 | 140 to 160 | |
| $I_{T(AV)}$ | 50 | 50 | A |
| @ T_C | 94 | 90 | $^{\circ}C$ |
| $I_{T(RMS)}$ | 80 | 80 | A |
| I_{TSM} | | | |
| @ 50Hz | 1430 | 1200 | A |
| @ 60Hz | 1490 | 1257 | A |
| I^2t | | | |
| @ 50Hz | 10.18 | 7.21 | KA^2s |
| @ 60Hz | 9.30 | 6.58 | KA^2s |
| V_{DRM}/V_{RRM} | 100 to 1200 | 1400 to 1600 | V |
| t_q typical | 110 | | μs |
| T_J | - 40 to 125 | | $^{\circ}C$ |



50RIA Series

Bulletin I2401 rev. A 07/00

International
IRF Rectifier

E E T R I A S P E C I F I C A T I O N S

Voltage Ratings

| Type number | Voltage Code | V_{DRM}/V_{RRM} , max. repetitive peak and off-state voltage (1) V | V_{RSM} , maximum non-repetitive peak voltage (2) V | I_{DRM}/I_{RRM} max. @ $T_J = T_J$ max. mA |
|-------------|--------------|---|--|--|
| 50RIA | 10 | 100 | 150 | 15 |
| | 20 | 200 | 300 | |
| | 40 | 400 | 500 | |
| | 60 | 600 | 700 | |
| | 80 | 800 | 900 | |
| | 100 | 1000 | 1100 | |
| | 120 | 1200 | 1300 | |
| | 140 | 1400 | 1500 | |
| | 160 | 1600 | 1700 | |

(1) Units may be broken over non-repetitively in the off-state direction without damage, if di/dt does not exceed $20A/\mu s$

(2) For voltage pulses with $t_p \leq 5ms$

On-state Conduction

| Parameter | 50RIA | | Units | Conditions | | |
|---|-----------|------------|----------------|--|----------------|---|
| | 10 to 120 | 140 to 160 | | | | |
| $I_{T(AV)}$ Max. average on-state current @ Case temperature | 50 | 50 | A | 180° sinusoidal conduction | | |
| | 94 | 90 | °C | | | |
| $I_{T(RMS)}$ Max. RMS on-state current | 80 | 80 | A | | | |
| I_{TSM} Max. peak, one-cycle non-repetitive surge current | 1430 | 1200 | A | t = 10ms | No voltage | Sinusoidal half wave, Initial $T_J = T_J$ max. |
| | 1490 | 1257 | | t = 8.3ms | reapplied | |
| | 1200 | 1010 | | t = 10ms | 100% V_{RRM} | |
| | 1255 | 1057 | | t = 8.3ms | reapplied | |
| I^2t Maximum I^2t for fusing | 10.18 | 7.21 | KA^2s | t = 10ms | No voltage | |
| | 9.30 | 6.58 | | t = 8.3ms | reapplied | |
| | 7.20 | 5.10 | | t = 10ms | 100% V_{RRM} | |
| | 6.56 | 4.65 | | t = 8.3ms | reapplied | |
| $I^2\sqrt{t}$ Maximum $I^2\sqrt{t}$ for fusing | 101.8 | 72.1 | $KA^2\sqrt{s}$ | t = 0.1 to 10ms, no voltage reapplied, $T_J = T_J$ max. | | |
| $V_{T(TO)1}$ Low level value of threshold voltage | 0.94 | 1.02 | V | $(16.7\% \times \pi \times I_{T(AV)} < I < \pi \times I_{T(AV)})$, $T_J = T_J$ max. | | |
| $V_{T(TO)2}$ High level value of threshold voltage | 1.08 | 1.17 | | $(\pi \times I_{T(AV)} < I < 20 \times \pi \times I_{T(AV)})$, $T_J = T_J$ max. | | |
| r_{T1} Low level value of on-state slope resistance | 4.08 | 4.78 | mΩ | $(16.7\% \times \pi \times I_{T(AV)} < I < \pi \times I_{T(AV)})$, $T_J = T_J$ max. | | |
| r_{T2} High level value of on-state slope resistance | 3.34 | 3.97 | | $(\pi \times I_{T(AV)} < I < 20 \times \pi \times I_{T(AV)})$, $T_J = T_J$ max. | | |
| V_{TM} Max. on-state voltage | 1.60 | 1.78 | V | $I_{pk} = 157 A$, $T_J = 25^\circ C$ | | |
| I_H Maximum holding current | 200 | | mA | $T_J = 25^\circ C$. Anode supply 22V, resistive load, Initial $I_T = 2A$ | | |
| I_L Latching current | 400 | | | Anode supply 6V, resistive load | | |

Switching

| Parameter | 50RIA | Units | Conditions |
|---|------------|------------|---|
| di/dt Max. rate of rise of turned-on current $V_{DRM} \leq 600V$ $V_{DRM} \leq 1600V$ | 200 100 | A/ μs | $T_C = 125^\circ C$, $V_{DM} = \text{rated } V_{DRM}$ Gate pulse = 20V, 15Ω , $t_p = 6\mu s$, $t_r = 0.1\mu s$ max. $I_{TM} = (2x \text{ rated } di/dt) A$ |
| t_d Typical delay time | 0.9 | μs | $T_C = 25^\circ C$ $V_{DM} = \text{rated } V_{DRM}$ $I_{TM} = 10A$ dc resistive circuit Gate pulse = 10V, 15Ω source, $t_p = 20\mu s$ |
| t_q Typical turn-off time | 110 | | $T_C = 125^\circ C$, $I_{TM} = 50A$, reapplied $dv/dt = 20V/\mu s$ $dir/dt = -10A/\mu s$, $V_R=50V$ |

Blocking

| Parameter | 50RIA | Units | Conditions |
|---|---------|-----------|---|
| dv/dt Max. critical rate of rise of off-state voltage | 200 | $V/\mu s$ | $T_J = T_J$ max. linear to 100% rated V_{DRM} |
| | 500 (*) | | $T_J = T_J$ max. linear to 67% rated V_{DRM} |

(*) Available with $dv/dt = 1000V/\mu s$, to complete code add S90 i.e. 50RIA160S90.

Triggering

| Parameter | 50RIA | Units | Conditions |
|--|-------|-------|--|
| P_{GM} Maximum peak gate power | 10 | W | $T_J = T_J$ max, $t_p \leq 5ms$ |
| $P_{G(AV)}$ Maximum average gate power | 2.5 | | |
| I_{GM} Max. peak positive gate current | 2.5 | A | |
| $+V_{GM}$ Maximum peak positive gate voltage | 20 | V | |
| $-V_{GM}$ Maximum peak negative gate voltage | 10 | | |
| I_{GT} DC gate current required to trigger | 250 | mA | $T_J = -40^\circ C$ $T_J = 25^\circ C$ $T_J = 125^\circ C$ Max. required gate trigger current/voltage are the lowest value which will trigger all units 6V anode-to-cathode applied |
| | 100 | | |
| | 50 | | |
| V_{GT} DC gate voltage required to trigger | 3.5 | V | $T_J = -40^\circ C$ $T_J = 25^\circ C$ |
| | 2.5 | | |
| I_{GD} DC gate current not to trigger | 5.0 | mA | $T_J = T_J$ max $V_{DRM} = \text{rated voltage}$ Max. gate current/ voltage not to trigger is the max. value which will not trigger any unit with rated V_{DRM} anode-to-cathode applied |
| V_{GD} DC gate voltage not to trigger | 0.2 | V | $T_J = T_J$ max |

50RIA Series

Bulletin I2401 rev. A 07/00

International
IRF Rectifier

Thermal and Mechanical Specification

| Parameter | 50RIA | Units | Conditions |
|---|------------------|----------|--|
| T _J Max. operating temperature range | - 40 to 125 | °C | |
| T _{stg} Max. storage temperature range | - 40 to 125 | °C | |
| R _{thJC} Max. thermal resistance, junction to case | 0.35 | K/W | DC operation |
| R _{thCS} Max. thermal resistance, case to heatsink | 0.25 | K/W | Mounting surface, smooth, flat and greased |
| T Mounting torque | Min. 2.8 (25) | Nm | Non-lubricated threads |
| | Max. 3.4 (30) | (lbf-in) | |
| wt Approximate weight | 28 (1.0) | g (oz) | |
| Case style | TO-208AC (TO-65) | | See Outline Table |

ΔR_{thJC} Conduction

(The following table shows the increment of thermal resistance R_{thJC} when devices operate at different conduction angles than DC)

| Conduction angle | Sinusoidal conduction | Rectangular conduction | Units | Conditions |
|------------------|-----------------------|------------------------|-------|--------------------------------------|
| 180° | 0.078 | 0.057 | K/W | T _J = T _J max. |
| 120° | 0.094 | 0.098 | | |
| 90° | 0.120 | 0.130 | | |
| 60° | 0.176 | 0.183 | | |
| 30° | 0.294 | 0.296 | | |

Ordering Information Table

| Device code | |
|-------------|--|
| | |
| - | Current code |
| - | Essential part number |
| - | Voltage code: Code x 10 = V _{RRM} (See Voltage Rating Table) |
| - | Critical dv/dt: None = 500V/μs (Standard value) S90 = 1000V/μs (Special selection) |
| - | None = Stud base TO-208AC (TO-65) 1/4" 28UNF-2A M = Stud base TO-208AC (TO-65) M6 X 1 |

Outline Table

| |
|--|
| |
|--|

| | |
|-----|--|
| 130 | 50RIA Series (100V to 1200V) R_{thJC} (DC) = 0.35 K/W |
|-----|--|

50RIA Series

Bulletin I2401 rev. A 07/00

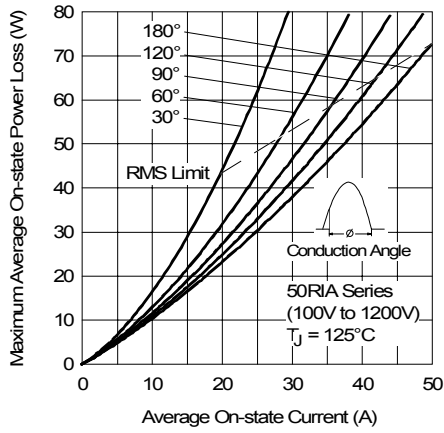


Fig. 3 - On-state Power Loss Characteristics

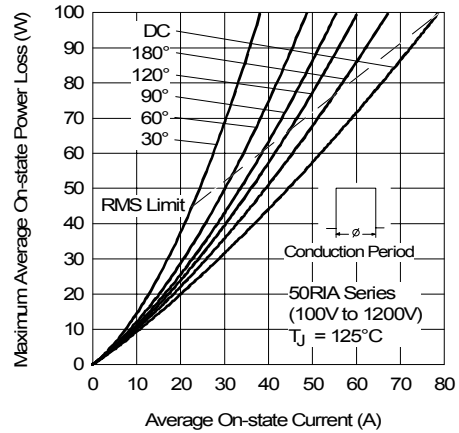


Fig. 4 - On-state Power Loss Characteristics

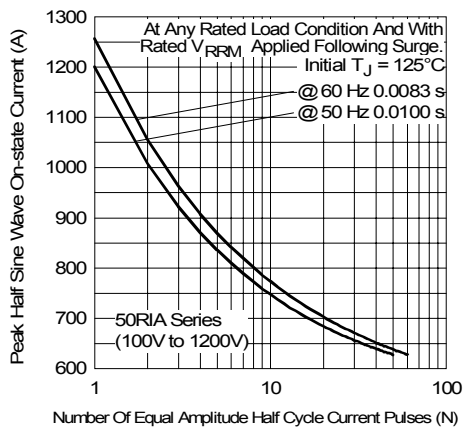


Fig. 5 - Maximum Non-Repetitive Surge Current

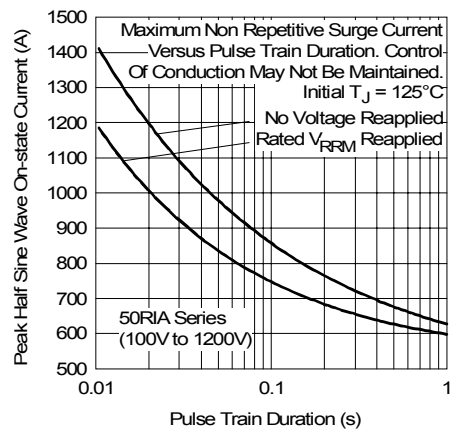


Fig. 6 - Maximum Non-Repetitive Surge Current

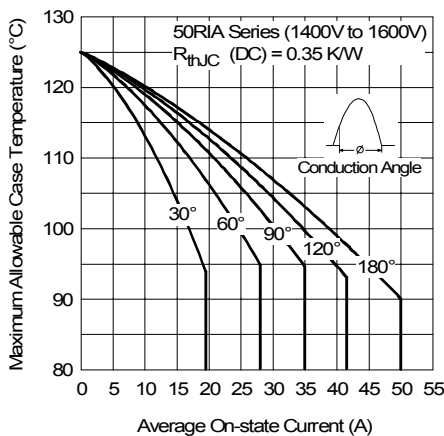


Fig. 7 - Current Ratings Characteristics

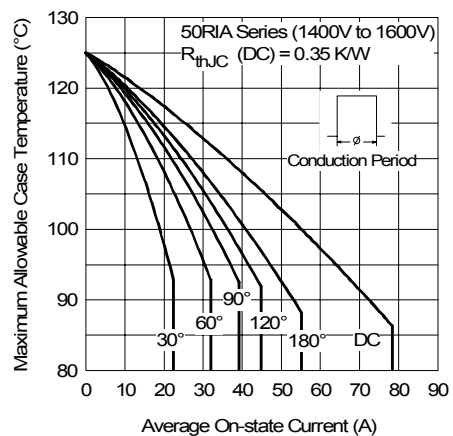


Fig. 8 - Current Ratings Characteristics

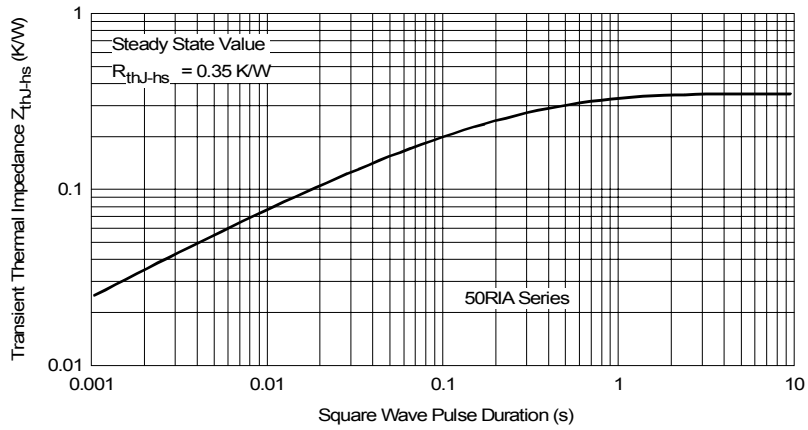


Fig. 15 - Thermal Impedance Z_{thJC} Characteristics

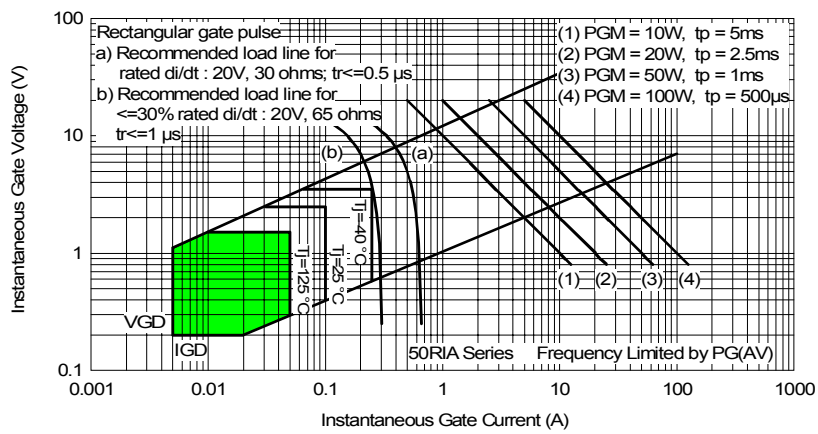


Fig. 16 - Gate Characteristics